

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/552,054	LIEB, MARKUS	
		Examiner	Art Unit	Page 1 of 2
		Sonny TRINH	2618	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,324,466	01-2008	Matsuo, Naoshi	370/286
*	B	US-7,221,622	05-2007	Matsuo et al.	367/125
*	C	US-7,072,310	07-2006	Matsuo, Naoshi	370/286
*	D	US-6,889,066	05-2005	Gupta et al.	455/570
*	E	US-6,799,062	09-2004	Piket et al.	455/569.1
*	F	US-6,768,914	07-2004	Garey, Kenneth E.	455/569.1
*	G	US-6,662,027	12-2003	Chia et al.	455/570
*	H	US-5,909,489	06-1999	Matt et al.	379/406.08
*	I	US-5,696,821	12-1997	Urbanski, Steven Adam	379/406.07
*	J	US-5,636,323	06-1997	Umemoto et al.	704/226
*	K	US-5,263,079	11-1993	Umemoto, Yuji	455/553.1
*	L	US-7,035,398	04-2006	Matsuo, Naoshi	379/406.06
*	M	US-6,795,558	09-2004	Matsuo, Naoshi	381/92

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
e	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/552,054	LIEB, MARKUS	
Examiner		Art Unit		Page 2 of 2
Sonny TRINH		2618		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,600,824	07-2003	Matsuo, Naoshi	381/92
*	B	US-6,757,394	06-2004	Matsuo, Naoshi	381/92
*	C	US-6,526,147	02-2003	Rung, Martin	381/92
*	D	US-6,480,824	11-2002	Christensson et al.	704/233
*	E	US-5,610,991	03-1997	Janse, Cornelis P.	381/92
*	F	US-5,696,821	12-1997	Urbanski, Steven Adam	379/406.07
*	G	US-5,835,607	11-1998	Martin et al.	381/94.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.